4-Bit 24 Mb/s Dual-Supply Level Translator

The NLSX4378 is a 4-bit configurable dual-supply bidirectional auto sensing translator that does not require a directional control pin. The V_{CC} I/O and V_L I/O ports are designed to track two different power supply rails, V_{CC} and V_L respectively. The V_{CC} supply rail is configurable from 1.65 V to 5.5 V while V_L supply rail is configurable to 1.65 V to 5.5 V. This allows voltage logic signals on the V_L side to be translated into lower, higher or equal value voltage logic signals on the V_{CC} side, and vice-versa.

The NLSX4378 translator has open-drain outputs with integrated 10 $k\Omega$ pullup resistors on the I/O lines. The integrated pullup resistors are used to pullup the I/O lines to either V_L or V_{CC} . The NLSX4378 is an excellent match for open-drain applications such as the I²C communication bus.

Features

- ullet V_L can be Less than, Greater than or Equal to V_{CC}
- Wide V_{CC} Operating Range: 1.65 V to 5.5 V Wide V_L Operating Range: 1.65 V to 5.5 V
- High-Speed with 24 Mb/s Guaranteed Date Rate
- Low Bit-to-Bit Skew
- Enable Input and I/O Lines have Overvoltage Tolerant (OVT) to 5.5 V
- Nonpreferential Powerup Sequencing
- Integrated 10 kΩ Pullup Resistors
- Small Space Saving Package 2.02 x 1.54 mm μBump12
- This is a Pb-Free Device

Typical Applications

- I²C, SMBus, PMBus
- Low Voltage ASIC Level Translation
- Mobile Phones, PDAs, Cameras



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μBump12 FC SUFFIX CASE 499AU



O S4378x AYWW

c = F - Standard

B - Backcoated

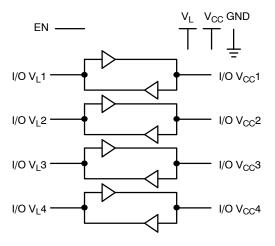
A = Assembly Location

Y = Year

WW = Work Week

= Pb-Free Package

LOGIC DIAGRAM



ORDERING INFORMATION

See detailed ordering and shipping information in the package dimensions section on page 8 of this data sheet.

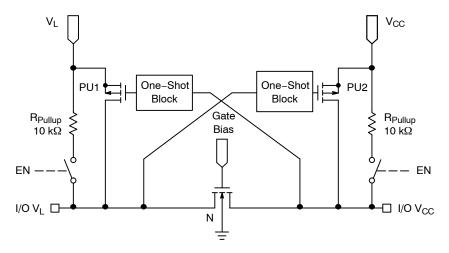


Figure 1. Block Diagram (1 I/O Line)

PIN ASSIGNMENT

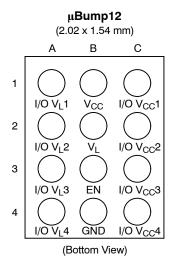
Pins	Description	
V _{CC}	V _{CC} Input Voltage	
V_L	V _L Input Voltage	
GND	Ground	
EN	Output Enable	
I/O V _{CC} n	V _{CC} I/O Port, Referenced to V _{CC}	
I/O V _L n	V _L I/O Port, Referenced to V _L	

FUNCTION TABLE

EN	Operating Mode	
L	Hi–Z	
Н	I/O Buses Connected	

PIN LOCATION

Pin	Pin Name	
A1	I/O V _L 1	
A2	I/O V _L 2	
A3	I/O V _L 3	
A4	I/O VL4	
B1	Vcc	
B2	V_L	
В3	EN	
B4	GND	
C1	I/O V _{CC} 1	
C2	I/O V _{CC} 2	
C3	I/O V _{CC} 3	
C4	I/O V _{CC} 4	



MAXIMUM RATINGS

Symbol	Parameter	Condition	Value	Unit
V _{CC}	DC Supply Voltage		-0.3 to +7.0	٧
V _L	DC Supply Voltage		-0.3 to +7.0	٧
I/O V _{CC}	V _{CC} -Referenced DC Input/Output Voltage		-0.3 to (V _{CC} + 0.3)	٧
I/O V _L	V _L -Referenced DC Input/Output Voltage		-0.3 to (V _L + 0.3)	V
V _{EN}	Enable Control Pin DC Input Voltage		-0.3 to +7.0	V
I _{I/O_SC}	Short-Circuit Duration (I/O V _L and I/O V _{CC} to GND)	Continuous	40	mA
T _{STG}	Storage Temperature		-65 to +150	°C

Stresses exceeding Maximum Ratings may damage the device. Maximum Ratings are stress ratings only. Functional operation above the Recommended Operating Conditions is not implied. Extended exposure to stresses above the Recommended Operating Conditions may affect device reliability.

RECOMMENDED OPERATING CONDITIONS

Symbol	Parameter	Min	Max	Unit
V _{CC}	DC Supply Voltage	1.65	5.5	V
V _L	DC Supply Voltage	1.65	5.5	V
V _{EN}	Enable Control Pin Voltage	GND	5.5	٧
V _{IO}	Enable Control Pin Voltage	GND	5.5	٧
T _A	Operating Temperature Range	-40	+85	°C

DC ELECTRICAL CHARACTERISTICS (V_{CC} = 1.65 V to 5.5 V and V_{L} = 1.65 V to 5.5 V, unless otherwise specified)

			_	40°C to +85°	C	
Symbol	Parameter	Test Conditions	Min	Typ (Notes 1, 2)	Max	Unit
V _{IHC}	I/O V _{CC} Input HIGH Voltage		V _{CC} - 0.4	-	-	V
V _{ILC}	I/O V _{CC} Input LOW Voltage		-	-	0.15	V
V _{IHL}	I/O V _L Input HIGH Voltage		V _L – 0.4	-	-	V
V _{ILL}	I/O V _L Input LOW Voltage		-	-	0.15	V
V _{IH}	Control Pin Input HIGH Voltage		0.65 * V _L	-	-	V
V _{IL}	Control Pin Input LOW Voltage		-	-	0.35 * V _L	V
V _{OHC}	I/O V _{CC} Output HIGH Voltage	I/O V _{CC} Source Current = 20 μA	0.8 * V _{CC}	-	-	V
V _{OLC}	I/O V _{CC} Output LOW Voltage	I/O V_{CC} Sink Current = 1.0 mA I/O_ $V_L \le 0.15 \text{ V}$	-	-	0.4	V
V _{OHL}	I/O V _L Output HIGH Voltage	I/O V _L Source Current = 20 μA	0.8 * V _L	-	-	V
V _{OLL}	I/O V _L Output LOW Voltage	I/O V_L Sink Current = 1.0 mA I/O_ $V_{CC} \le 0.15 \text{ V}$	-	-	0.4	V
I _{QVCC}	V _{CC} Supply Current	I/O V_{CC} and I/O V_L Unconnected, $V_{EN} = V_L$	-	0.5	2.0	μΑ
I _{QVL}	V _L Supply Current	I/O V_{CC} and I/O V_L Unconnected, $V_{EN} = V_L$	-	0.3	1.0	μΑ
I _{TS-VCC}	V _{CC} Tristate Output Mode Supply Current	I/O V_{CC} and I/O V_L Unconnected, V_{EN} = GND	-	0.1	1.0	μΑ
I _{TS-VL}	V _L Tristate Output Mode Supply Current	I/O V_{CC} and I/O V_L Unconnected, V_{EN} = GND	-	0.1	1.0	μΑ
l _{OZ}	I/O Tristate Output Mode Leakage Current	T _A = +25°C	-	0.1	1.0	μА
R _{PU}	Pullup Resistor I/O V _L and V _{CC}	T _A = +25°C	-	10	-	kΩ

Typical values are for V_{CC} = +2.8 V, V_L = +1.8 V and T_A = +25°C.
 All units are production tested at T_A = +25°C. Limits over the operating temperature range are guaranteed by design.

TIMING CHARACTERISTICS - RAIL-TO-RAIL DRIVING CONFIGURATIONS

(I/O test circuit of Figures 2 and 3, C_{LOAD} = 15 pF, driver output impedance \leq 50 Ω , R_{LOAD} = 1 M Ω)

			-4	-40°C to +85°C (Note 3)		
Symbol	Parameter	Test Conditions	Min	Тур	Max	Unit
V _L = 1.65 V,	V _{CC} = 5.5 V		•		•	•
t _{RVCC}	I/O V _{CC} Risetime				15	ns
t _{FVCC}	I/O V _{CC} Falltime				20	ns
t _{RVL}	I/O V _L Risetime				30	ns
t _{FVL}	I/O V _L Falltime				10	ns
t _{PDVL-VCC}	Propagation Delay (Driving I/O V _L)				20	ns
t _{PDVCC-VL}	Propagation Delay (Driving I/O V _{CC})				20	ns
t _{PPSKEW}	Part-to-Part Skew				5	nS
MDR	Maximum Data Rate		24			Mb/s
V _L = 1.8 V, \	/ _{CC} = 2.8 V	'			1	4
t _{RVCC}	I/O V _{CC} Risetime				15	ns
t _{FVCC}	I/O V _{CC} Falltime				15	ns
t _{RVL}	I/O V _L Risetime				25	ns
t _{FVL}	I/O V _L Falltime				10	ns
t _{PDVL-VCC}	Propagation Delay (Driving I/O V _L)				15	ns
t _{PDVCC-VL}	Propagation Delay (Driving I/O V _{CC})				15	ns
t _{PPSKEW}	Part-to-Part Skew				5	nS
MDR	Maximum Data Rate		24			Mb/s
V _L = 2.5 V, \	/ _{CC} = 3.6 V		•		•	•
t _{RVCC}	I/O V _{CC} Risetime				15	ns
t _{FVCC}	I/O V _{CC} Falltime				10	ns
t _{RVL}	I/O V _L Risetime				15	ns
t _{FVL}	I/O V _L Falltime				10	ns
t _{PDVL-VCC}	Propagation Delay (Driving I/O V _L)				15	ns
t _{PDVCC-VL}	Propagation Delay (Driving I/O V _{CC})				15	ns
t _{PPSKEW}	Part-to-Part Skew				5	nS
MDR	Maximum Data Rate		24			Mb/s
V _L = 2.8 V, \	/ _{CC} = 1.8 V	•	· · ·		•	+
t _{RVCC}	I/O V _{CC} Risetime				25	ns
t _{FVCC}	I/O V _{CC} Falltime				10	ns
t _{RVL}	I/O V _L Risetime				20	ns
t _{FVL}	I/O V _L Falltime				15	ns
t _{PDVL-VCC}	Propagation Delay (Driving I/O V _L)				15	ns
t _{PDVCC-VL}	Propagation Delay (Driving I/O V _{CC})				15	ns
t _{PPSKEW}	Part-to-Part Skew				5	nS
MDR	Maximum Data Rate		24			Mb/s

^{3.} All units are production tested at $T_A = +25$ °C. Limits over the operating temperature range are guaranteed by design.

NI SX4378

TIMING CHARACTERISTICS - RAIL-TO-RAIL DRIVING CONFIGURATIONS

(I/O test circuit of Figures 2 and 3, C_{LOAD} = 15 pF, driver output impedance \leq 50 Ω , R_{LOAD} = 1 M Ω)

				-40°C to +85°C (Note 3)		
Symbol	Parameter	Test Conditions	Min	Тур	Max	Unit
V _L = 3.6 V, \	/ _{CC} = 2.5 V				•	•
t _{RVCC}	I/O V _{CC} Risetime				15	ns
t _{FVCC}	I/O V _{CC} Falltime				10	ns
t _{RVL}	I/O V _L Risetime				15	ns
t _{FVL}	I/O V _L Falltime				15	ns
t _{PDVL-VCC}	Propagation Delay (Driving I/O V _L)				15	ns
t _{PDVCC-VL}	Propagation Delay (Driving I/O V _{CC})				15	ns
t _{PPSKEW}	Part-to-Part Skew				5	nS
MDR	Maximum Data Rate		24			Mb/s
V _L = 5.5 V, \	/ _{CC} = 1.65 V					
t _{RVCC}	I/O V _{CC} Risetime				30	ns
t _{FVCC}	I/O V _{CC} Falltime				10	ns
t _{RVL}	I/O V _L Risetime				15	ns
t _{FVL}	I/O V _L Falltime				20	ns
t _{PDVL-VCC}	Propagation Delay (Driving I/O V _L)				20	ns
t _{PDVCC-VL}	Propagation Delay (Driving I/O V _{CC})				20	ns
t _{PPSKEW}	Part-to-Part Skew				5	nS
MDR	Maximum Data Rate		24			Mb/s

^{3.} All units are production tested at $T_A = +25$ °C. Limits over the operating temperature range are guaranteed by design.

TIMING CHARACTERISTICS - OPEN DRAIN DRIVING CONFIGURATIONS

(I/O test circuit of Figures 4 and 5, C_{LOAD} = 15 pF, driver output impedance \leq 50 Ω , R_{LOAD} = 1 M Ω)

			-4	0°C to +85 (Note 4)	°C	
Symbol	Parameter	Test Conditions	Min	Тур	Max	Unit
+1.65 ≤ V _L ,	$V_{CC} \le +5.5 V$					
t _{RVCC}	I/O V _{CC} Risetime				400	ns
t _{FVCC}	I/O V _{CC} Falltime				50	ns
t _{RVL}	I/O V _L Risetime				400	ns
t _{FVL}	I/O V _L Falltime				60	ns
t _{PDVL-VCC}	Propagation Delay (Driving I/O V _L)				1000	ns
t _{PDVCC-VL}	Propagation Delay (Driving I/O V _{CC})				1000	ns
t _{PPSKEW}	Part-to-Part Skew				50	nS
MDR	Maximum Data Rate		2			Mb/s

^{4.} All units are production tested at T_A = +25°C. Limits over the operating temperature range are guaranteed by design. Limits over the operating temperature range are guaranteed by design.

TEST SETUPS

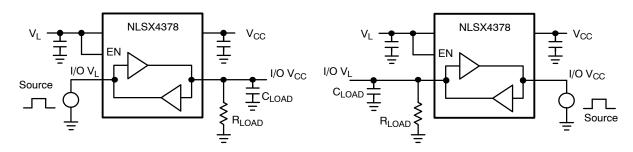


Figure 2. Rail-to-Rail Driving I/O V_L

Figure 3. Rail-to-Rail Driving I/O V_{CC}

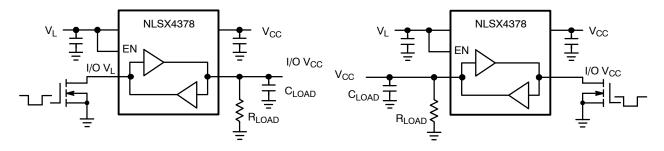


Figure 4. Open-Drain Driving I/O V_L

Figure 5. Open-Drain Driving I/O V_{CC}

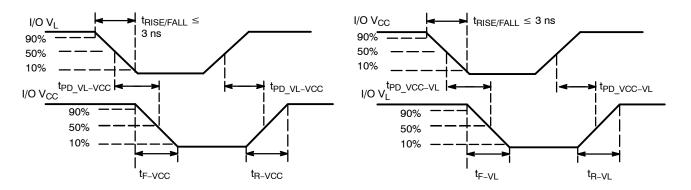
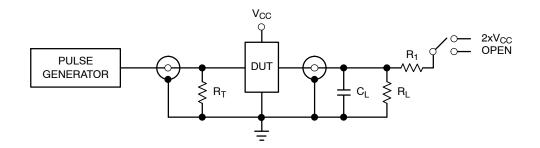


Figure 6. Definition of Timing Specification Parameters



Test	Switch
t _{PZH} , t _{PHZ}	Open
t _{PZL} , t _{PLZ}	2 x V _{CC}

 C_L = 15 pF or equivalent (Includes jig and probe capacitance) R_L = R_1 = 50 k Ω or equivalent R_T = Z_{OUT} of pulse generator (typically 50 Ω)

Figure 7. Test Circuit for Enable/Disable Time Measurement

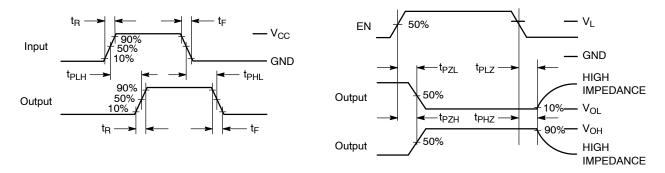


Figure 8. Timing Definitions for Propagation Delays and Enable/Disable Measurement

APPLICATIONS INFORMATION

Level Translator Architecture

The NLSX4378 auto sense translator provides bi–directional voltage level shifting to transfer data in multiple supply voltage systems. This device has two supply voltages, V_L and V_{CC} , which set the logic levels on the input and output sides of the translator. When used to transfer data from the V_L to the V_{CC} ports, input signals referenced to the V_L supply are translated to output signals with a logic level matched to V_{CC} . In a similar manner, the V_{CC} to V_L translation shifts input signals with a logic level compatible to V_{CC} to an output signal matched to V_L .

The NLSX4378 consists of two bi-directional channels that independently determine the direction of the data flow without requiring a directional pin. The one-shot circuits are used to detect the rising input signals. In addition, the one shots decrease the rise time of the output signal for low-to-high transitions.

Each input/output channel has an internal $10~k\Omega$ pull. The magnitude of the pullup resistors can be reduced by connecting external resistors in parallel to the internal $10~k\Omega$ resistors.

Input Driver Requirements

The rise (t_R) and fall (t_F) timing parameters of the open drain outputs depend on the magnitude of the pull-up resistors. In addition, the propagation times (t_{PD}), skew (t_{PSKEW}) and maximum data rate depend on the impedance of the device that is connected to the translator. The timing

parameters listed in the data sheet assume that the output impedance of the drivers connected to the translator is less than $50~\Omega$.

Enable Input (EN)

The NLSX4378 has an Enable pin (EN) that provides tri–state operation at the I/O pins. Driving the Enable pin to a low logic level minimizes the power consumption of the device and drives the I/O $V_{\rm CC}$ and I/O $V_{\rm L}$ pins to a high impedance state. Normal translation operation occurs when the EN pin is equal to a logic high signal. The EN pin is referenced to the $V_{\rm L}$ supply and has Overvoltage Tolerant (OVT) protection.

Power Supply Guidelines

During normal operation, supply voltage V_L can be greater than, less than or equal to V_{CC} . The sequencing of the power supplies will not damage the device during the power up operation.

For optimal performance, 0.01 μF to 0.1 μF decoupling capacitors should be used on the V_L and V_{CC} power supply pins. Ceramic capacitors are a good design choice to filter and bypass any noise signals on the voltage lines to the ground plane of the PCB. The noise immunity will be maximized by placing the capacitors as close as possible to the supply and ground pins, along with minimizing the PCB connection traces.

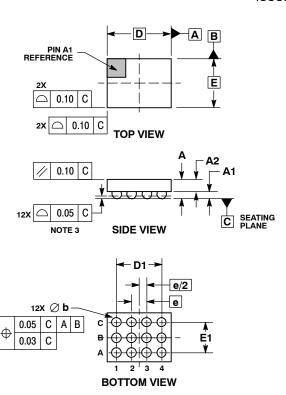
ORDERING INFORMATION

Device	Package	Shipping [†]
NLSX4378FCT1G	μBump12 (Pb-Free)	3000 / Tape & Reel
NLSX4378BFCT1G	μBump12 (Backside Laminate Coating) (Pb–Free)	3000 / Tape & Reel

[†]For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

PACKAGE DIMENSIONS

μBump12, 2.02x1.54, 0.5P CASE 499AU **ISSUE O**



- NOTES:
 1. DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 1994.
 2. CONTROLLING DIMENSION: MILLIMETERS.
- COPLANARITY APPLIES TO SPHERICAL CROWNS OF SOLDER BALLS.

	MILLIMETERS				
DIM	MIN	MAX			
Α		0.66			
A1	0.21	0.27			
A2	0.33	0.39			
b	0.29	0.34			
D	2.02	BSC			
D1	1.50	BSC			
Е	1.54 BSC				
E1	1.00	BSC			
е	0.50	BSC			

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MAX3371ELT+T NLSX3013BFCT1G NLV7WBD3125USG NLSX3012DMR2G 74AVCH1T45FZ4-7 NLVSV1T244MUTBG
74AVC1T45GS-Q100H CLVC16T245MDGGREP MC10H124FNG CAVCB164245MDGGREP CD40109BPWR MC10H350FNG
MC10H125FNG MC100EPT21MNR4G MC100EP91DWG NLSX3018MUTAG NLSV2T244MUTAG NLSX3013FCT1G
NLSX5011AMX1TCG PCA9306USG SN74GTL1655DGGR SN74AVCA406LZQSR NLSX4014DTR2G NLSX3018DTR2G
LTC1045CSW#PBF LTC1045CN#PBF SY100EL92ZG 74AXP1T34GMH 74AXP1T34GNH LSF0204DPWR PI4ULS3V204LE
ADG3245BRUZ-REEL7 ADG3123BRUZ ADG3245BRUZ ADG3246BCPZ ADG3308BCPZ-REEL ADG3233BRJZ-REEL7
ADG32233BRMZ